Preferred Devices

Silicon Power Transistors

The MJW21193 and MJW21194 utilize Perforated Emitter technology and are specifically designed for high power audio output, disk head positioners and linear applications.

- Total Harmonic Distortion Characterized
- High DC Current Gain
 - $h_{FE} = 20 \text{ Min } @ I_C = 8 \text{ Adc}$
- Excellent Gain Linearity
- High SOA: 2.25 A, 80 V, 1 Second

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V _{CEO}	250	Vdc
Collector-Base Voltage	V _{CBO}	400	Vdc
Emitter-Base Voltage	V _{EBO}	5.0	Vdc
Collector-Emitter Voltage - 1.5 V	V _{CEX}	400	Vdc
Collector Current – Continuous – Peak (Note 1)	Ι _C	16 30	Adc
Base Current – Continuous	Ι _Β	5.0	Adc
Total Power Dissipation @ T _C = 25°C Derate Above 25°C	P _D	200 1.43	Watts W/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	– 65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.7	°C/W
Thermal Resistance, Junction to Ambient	$R_{ hetaJA}$	40	°C/W

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

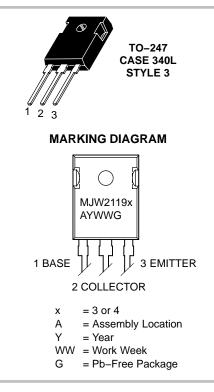
1. Pulse Test: Pulse Width = 5 μ s, Duty Cycle \leq 10%.



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16 A COMPLEMENTARY SILICON POWER TRANSISTORS 250 V, 200 W

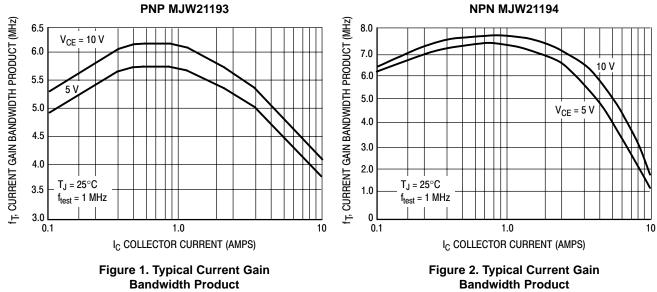


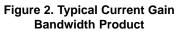
ORDERING INFORMATION

Device	Package	Shipping
MJW21193	TO-247	30 Units/Rail
MJW21193G	TO–247 (Pb–Free)	30 Units/Rail
MJW21194	TO-247	30 Units/Rail
MJW21194G	TO–247 (Pb–Free)	30 Units/Rail

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
DFF CHARACTERISTICS					
Collector–Emitter Sustaining Voltage $(I_C = 100 \text{ mAdc}, I_B = 0)$	V _{CEO(sus)}	250	-	-	Vdc
Collector Cutoff Current ($V_{CE} = 200 \text{ Vdc}, I_B = 0$)	I _{CEO}	-	-	100	μAdc
Emitter Cutoff Current ($V_{CE} = 5 Vdc, I_C = 0$)	I _{EBO}	-	_	100	μAdc
Collector Cutoff Current (V _{CE} = 250 Vdc, V _{BE(off)} = 1.5 Vdc)	ICEX	-	_	100	μAdc
SECOND BREAKDOWN	•				•
Second Breakdown Collector Current with Base Forward $(V_{CE} = 50 \text{ Vdc}, t = 1 \text{ s (non-repetitive)})$ $(V_{CE} = 80 \text{ Vdc}, t = 1 \text{ s (non-repetitive)})$	Biased I _{S/b}	4.0 2.25			Adc
ON CHARACTERISTICS					
DC Current Gain ($I_C = 8 \text{ Adc}, V_{CE} = 5 \text{ Vdc}$) ($I_C = 16 \text{ Adc}, I_B = 5 \text{ Adc}$)	h _{FE}	20 8		70 -	
Base–Emitter On Voltage (I _C = 8 Adc, V _{CE} = 5 Vdc)	V _{BE(on)}	-	_	2.2	Vdc
Collector–Emitter Saturation Voltage ($I_C = 8 \text{ Adc}, I_B = 0.8 \text{ Adc}$) ($I_C = 16 \text{ Adc}, I_B = 3.2 \text{ Adc}$)	V _{CE(sat)}	-		1.4 4	Vdc
DYNAMIC CHARACTERISTICS					
Total Harmonic Distortion at the Output $V_{RMS} = 28.3 \text{ V}, \text{ f} = 1 \text{ kHz}, P_{LOAD} = 100 \text{ W}_{RMS}$			0.0		%
(Matched pair h_{FE} = 50 @ 5 A/5 V) h_{FE}	natched	-	0.8 0.08	_	
Current Gain Bandwidth Product ($I_C = 1 \text{ Adc}, V_{CE} = 10 \text{ Vdc}, f_{test} = 1 \text{ MHz}$)	f _T	4	-	_	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f _{test} = 1 MHz)	C _{ob}	-	_	500	pF





TYPICAL CHARACTERISTICS

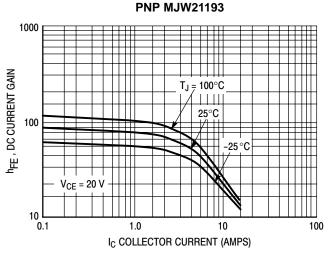
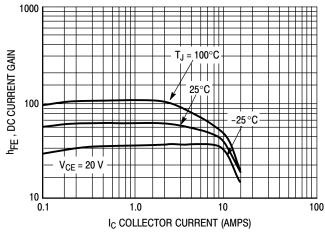
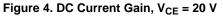


Figure 3. DC Current Gain, V_{CE} = 20 V



NPN MJW21194



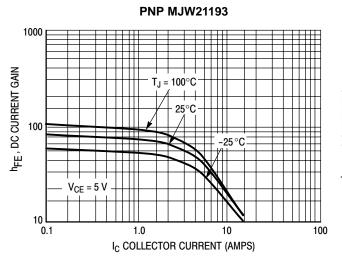
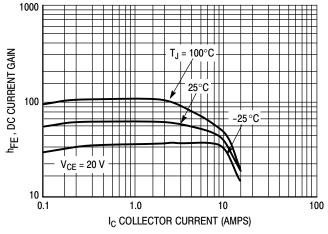


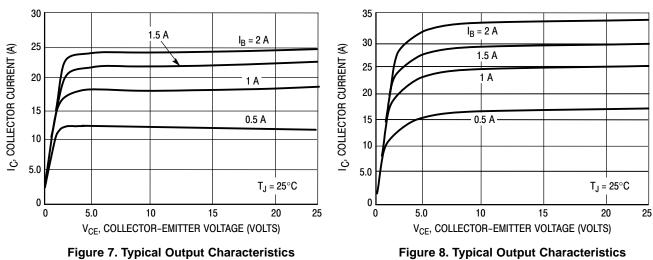
Figure 5. DC Current Gain, $V_{CE} = 5 V$







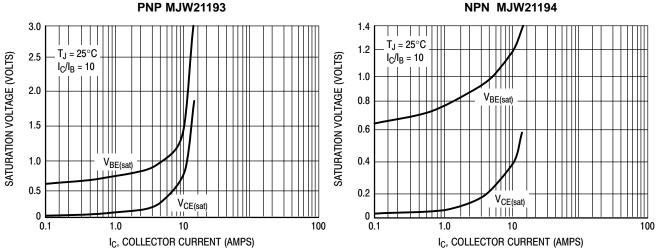
NPN MJW21194



PNP MJW21193

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TYPICAL CHARACTERISTICS









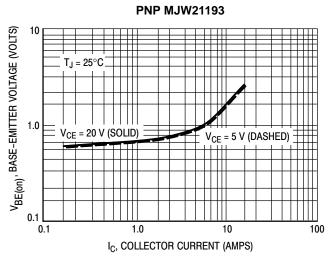


Figure 11. Typical Base-Emitter Voltage

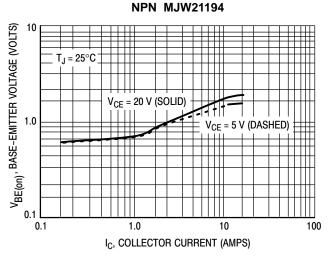
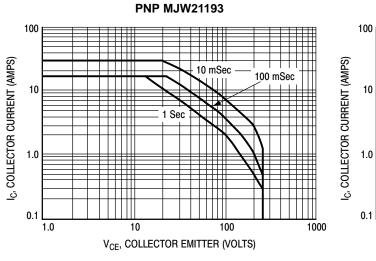
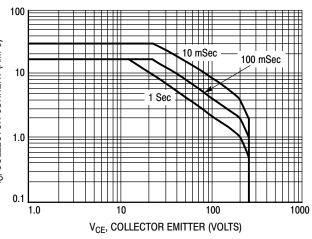


Figure 12. Typical Base-Emitter Voltage







NPN MJW21194



There are two limitations on the power handling ability of a transistor; average junction temperature and secondary breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 13 is based on $T_{J(pk)} = 150^{\circ}$ C; T_{C} is variable depending on conditions. At high case temperatures, thermal limitations will reduce the power than can be handled to values less than the limitations imposed by second breakdown.

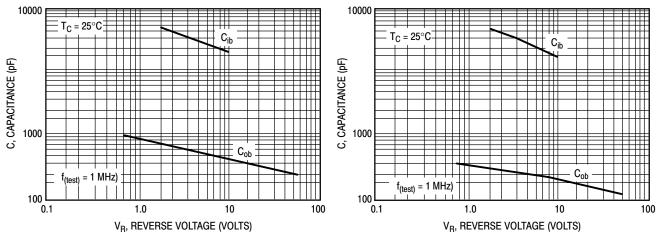


Figure 15. MJW21193 Typical Capacitance

Figure 16. MJW21194 Typical Capacitance

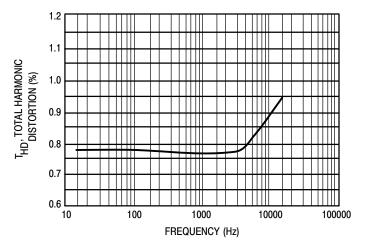


Figure 17. Typical Total Harmonic Distortion

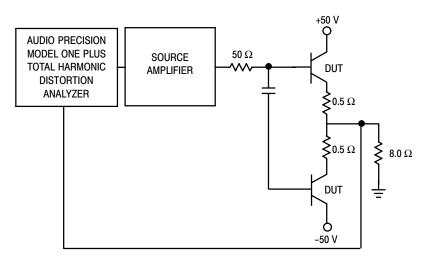
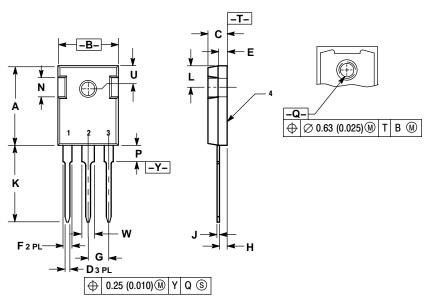


Figure 18. Total Harmonic Distortion Test Circuit

PACKAGE DIMENSIONS

TO-247 CASE 340L-02 ISSUE D



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: MILLIMETER.

	MILLIMETERS		INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	20.32	21.08	0.800	8.30	
В	15.75	16.26	0.620	0.640	
C	4.70	5.30	0.185	0.209	
D	1.00	1.40	0.040	0.055	
Е	2.20	2.60	0.087	0.102	
F	1.65	2.13	0.065	0.084	
G	5.45	5.45 BSC		0.215 BSC	
Η	1.50	2.49	0.059	0.098	
J	0.40	0.80	0.016	0.031	
K	20.06	20.83	0.790	0.820	
L	5.40	6.20	0.212	0.244	
Ν	4.32	5.49	0.170	0.216	
Р		4.50		0.177	
Q	3.55	3.65	0.140	0.144	
U	6.15 BSC 0.242 BSC		BSC		
W	2.87	3.12	0.113	0.123	

STYLE 3: PIN 1. BASE 2. COLLECTOR 3. EMITTER

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